**FDC5614P** 

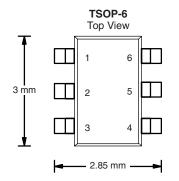


RoHS COMPLIANT HALOGEN

FREE

## P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Typ.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)		
-60	0.050 at V <sub>GS</sub> = -10 V	-6.5	10.1 nC		
	0.060 at V <sub>GS</sub> = -4.5 V	-5.1	10.1110		

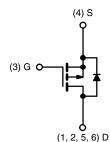


#### **FEATURES**

- TrenchFET<sup>®</sup> power MOSFET
- 100 %  $R_g$  and UIS tested

#### **APPLICATIONS**

- · Load switches
- DC/DC converter



P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25	5 °C, unless other	wise noted)		
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	-60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	
	T <sub>C</sub> = 25 °C		-6.5	
Continuous Drain Current (T. 150 °C)	T <sub>C</sub> = 70 °C	1 . [	-4.5	
Continuous Drain Current ( $T_J = 150 \ ^\circ C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-3.8 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C	1	-3.1 <sup>a,b</sup>	•
Pulsed Drain Current (t = 100 µs)		I <sub>DM</sub>	-20	Α
Continuous Source Drain Diade Current	T <sub>C</sub> = 25 °C		-3.5	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-1.7 <sup>a,b</sup>	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	-15	
Single-Pulse Avalanche Energy		E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		4.2	
Mauianum Danna Diasia atian	T <sub>C</sub> = 70 °C		2.7	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C	1	1.3 <sup>a,b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient a,c	t ≤ 10 s	R <sub>thJA</sub>	40	62.5	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	25	30	0/10	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on  $T_C = 25$  °C.

### **FDC5614P**

9	B	<sup>®</sup> VBsemi
	www	v.VBsemi.tw

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static			•					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	-60	-	-	V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = -250 μA		-6.7	-	mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			4.3	-			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$	-	-0.5	-	-2V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ± 20 V	-	-	± 100	nA		
Zero Gate Voltage Drain Current	lana	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	-1	μΑ		
Zero Gale Voltage Drain Gurrent	IDSS	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$	-	-	-5			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge$ -10 V, $V_{GS}$ = -10 V	-30	-	-	А		
Drain-Source On-State Resistance <sup>a</sup>	Base	$V_{GS}$ = -10 V, I <sub>D</sub> = -3.5 A	-	0.050	-	Ω		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -2.8 \text{ A}$	-	0.060	-			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = -30 \text{ V}, \text{ I}_{D} = -3.5 \text{ A}$	-	11	-	S		
Dynamic <sup>b</sup>								
Input Capacitance	C <sub>iss</sub>		-	832	-	pF		
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = -30 V, $V_{GS}$ = 0 V, f = 1 MHz	-	88	-			
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-			
Total Gate Charge	Qg	$V_{DS}$ = -30 V, $V_{GS}$ = -10 V, $I_{D}$ = -3.5 A	-	20	30	nC		
Total Gate Gharge			-	10.1	15.2			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = -30 V, $V_{GS}$ = -4.5 V, $I_{D}$ = -3.5 A	-	3.3	-			
Gate-Drain Charge	Q <sub>gd</sub>		-	3.9	-			
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1.8	9	18	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16			
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_{L}$ = 10.7 $\Omega$		6	12	1		
Turn-Off DelayTime	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong$ -2.8 A, $\text{V}_\text{GEN}$ = -10 V, $\text{R}_\text{g}$ = 1 $\Omega$	-	35	53			
Fall Time	t <sub>f</sub>		-	16	24			
Turn-On Delay Time	t <sub>d(on)</sub>		-	40	60	ns		
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_L$ = 10.7 $\Omega$	-	28	42			
Turn-Off DelayTime	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong\text{-2.8 A, V}_\text{GEN}=\text{-4.5 V, R}_\text{g}=1~\Omega$	-	31	47			
Fall Time	t <sub>f</sub>	1		15	23			
Drain-Source Body Diode Characterist	tics							
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-3.5	Δ		
Pulse Diode Forward Current (t = $100 \ \mu s$ )	I <sub>SM</sub>		-	-	-20	A		
Body Diode Voltage	V <sub>SD</sub>	$I_{\rm S}$ = -2.8 A, $V_{\rm GS}$ = 0 V	-	-0.85	-1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	32	48	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = -2.8 A, dl/dt = 100 A/μs,	-	45	68	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	T <sub>J</sub> = 25 °C		24	-			
Reverse Recovery Rise Time	t <sub>b</sub>		-	8	-	ns		

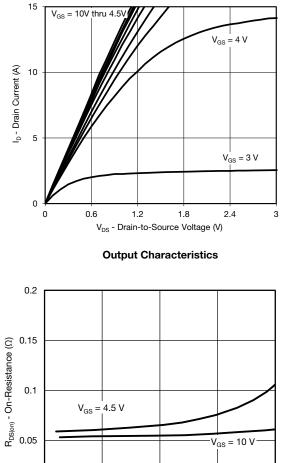
#### Notes

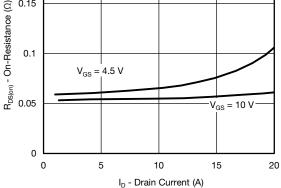
a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

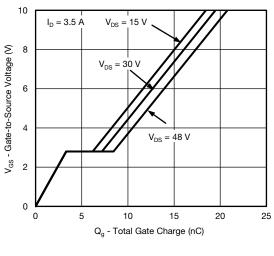
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



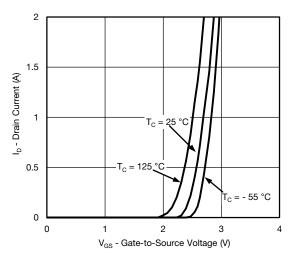




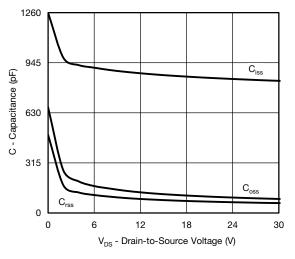




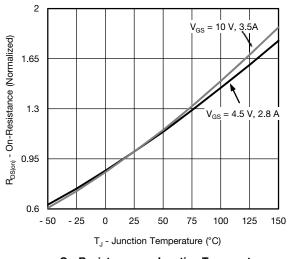
Gate Charge

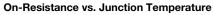


**Transfer Characteristics** 

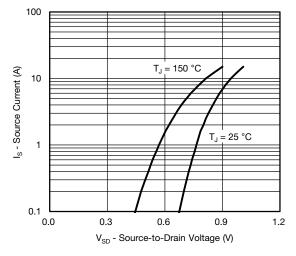




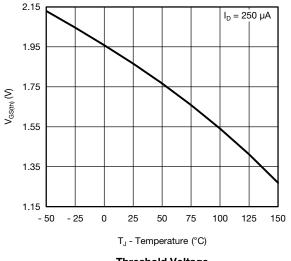




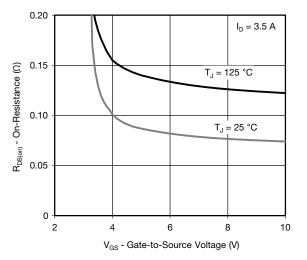




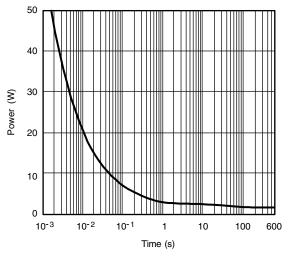
Source-Drain Diode Forward Voltage



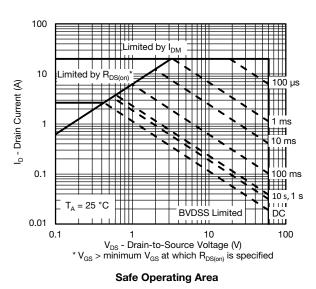
**Threshold Voltage** 



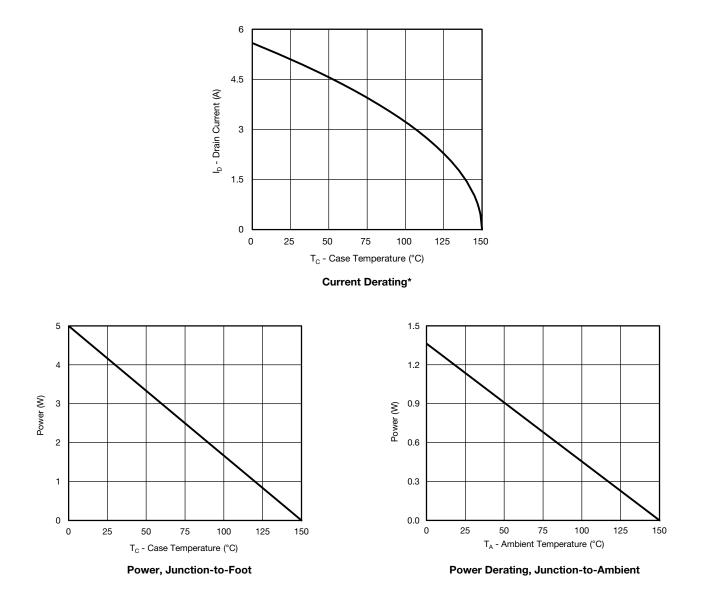
**On-Resistance vs. Gate-to-Source Voltage** 



Single Pulse Power, Junction-to-Ambient

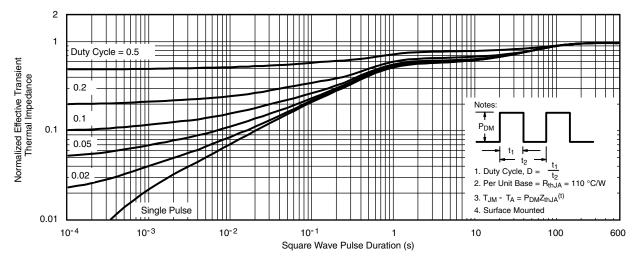




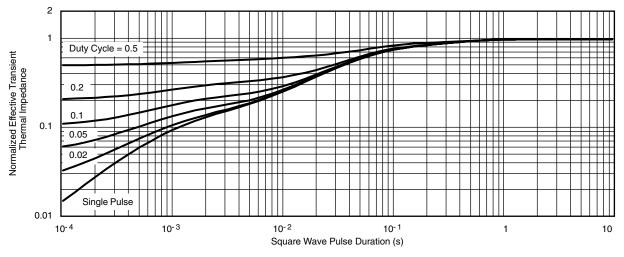


\* The power dissipation  $P_D$  is based on  $T_{J (max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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